## Search Notes



Application/Control	No.	

10538126 Examiner Applicant(s)/Patent Under Reexamination

KUROIWA ET AL.

Art Unit

1624

Jaisle, Cecilia M

SEARCHED					
Class	Subclass	Date	Examiner		
514	248	9/21/2007	Cecilia Jaisle		
540	461, 578	9/21/2007	Cecilia Jaisle		
544	235, 236	9/21/2007	Cecilia Jaisle		
514	248	5/7/2008	C. Jaisle		
544	235, 236	5/7/2008	C. Jaisle		

SEARCH NOTES		
Search Notes	Date	Examiner
STN and Inventor Names searched by STIC	9/21/2007	Cecilia Jaisle

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20080507